

**Search Notes**

Application/Control No.

10/626,736

Examiner

Vuthe Siek

Applicant(s)/Patent under  
Reexamination

LIN, CHE-SHENG

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	1,3,18	3/1/2005	VS
710	13-19	3/1/2005	VS
710	22-24,26	3/1/2005	VS
710	35-36,39	3/1/2005	VS
710	51,120	3/1/2005	VS
365	189.01-05	3/1/2005	VS
711	111-112	3/1/2005	VS
358	1.15-1.17	3/1/2005	VS
370	412,419	3/1/2005	VS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST all databases & IEEE	3/1/2005	VS